Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/721,326	SHIINA, MASAKI
Examiner	Art Unit
Emmanuel Sayoc	3746

		SEAR	CHED	
	Class	Subclass	Date	Examiner
	92	71x 165pg	12/20/08	(B)
		165 pr		
		1691		
	92	177x		<u> </u>
	417	269	142905	15
	417	269 222.1	6/29/06	6. r
-	417	222.1		
	92	71		
	92	165 R		
	92	169,1		
	92	177	1	V

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
Some o	o above	# 4/29/g	س سا
,			

SEARCH N (INCLUDING SEARC		r)
	DATE	EXMR
92-Loper 117-Reay	12/19/05	51
See tat seach	12/10/15	55
In addition: Invantuals and text search.	414.6	C.~
	>	